

**Search Notes**

Application/Control No.

10/790,579

Examiner

Anh D. Mai

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2814

**SEARCHED**

Class	Subclass	Date	Examiner
257	315-316 319; 322	8/22/2005	A.M
365	185.2; 185.16	8/22/2005	A.M

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST * Inventors * CCLS	8/22/2005	A.M